Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/517,366	HATANAKA ET AL.		
Examiner	Art Unit		
Thao T: Tran	1711		

SEARCHED				
Class	Subclass	Date	Examiner	
428	423.1	2/5/2007	ТТ	
	423.5			
	473.5			
	474.4			
528	44+			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST, including inventor name search	2/5/2007	тт
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